

## INFORMATION DISCLOSURE TRANSMITTAL

Docket No. B0004/7110

Applicant: Serial No:

Jochen Franzen 10/624,913

Filed: For: July 22, 2003 IONIZATION AT ATMOSPHERIC PRESSURE FOR MASS

SPECTROMETRIC ANALYSES

Examiner: Art Unit:

Not Yet Assigned Not Yet Assigned

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Alexandria, VA 22313-1450 on February 10, 2004.

Brenda A. Kantorski

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

In keeping with the duty of candor and good faith owed to the Patent and Trademark Office, Applicant wishes to bring information to the attention of the Examiner. The filing of this statement shall not be construed as a representation that a search has been made or as an admission that this information is, or is considered to be, material to patentability as defined in 37 C.F.R. §1.56(b).

## **Enclosures**

|             | A form PTO-1449 listing this information is attached A copy of each document cited is enclosed. Copies of the cited documents are not enclosed because .                                  |
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| Fees        |   |
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|             | allowance or an action that otherwise closes prosecution, and   |
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|             | each item of information contained in this statement was cited in a   |
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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT She t 1 of 1

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**ANALYSES** 

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Art Unit:

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| Examiner  | Date       |  |
|-----------|------------|--|
| Signature | Considered |  |